Dual P-Channel 1.8-V (G-S) MOSFET

CHARACTERISTICS

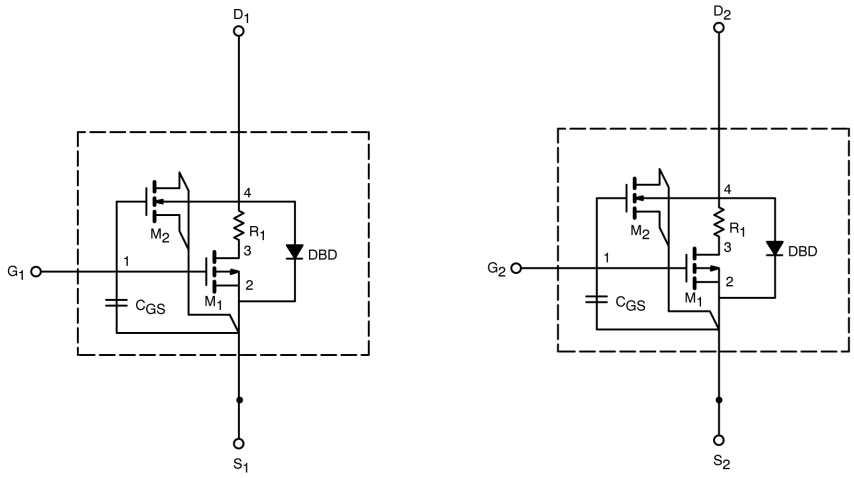
- P-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS
- Apply for both Linear and Switching Application
- Accurate over the −55 to 125°C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

DESCRIPTION

The attached spice model describes the typical electrical characteristics of the p-channel vertical DMOS. The subcircuit model schematic is extracted and optimized over the −55 to 125°C temperature ranges under the pulsed 0-to-5V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage.

A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched C_{gd} model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device(s).

SUBCIRCUIT MODEL SCHEMATIC

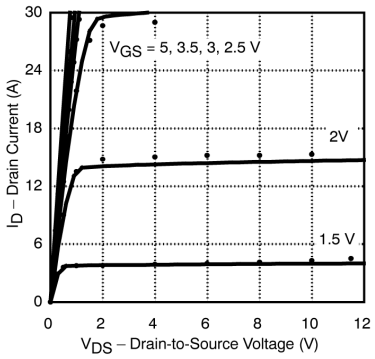


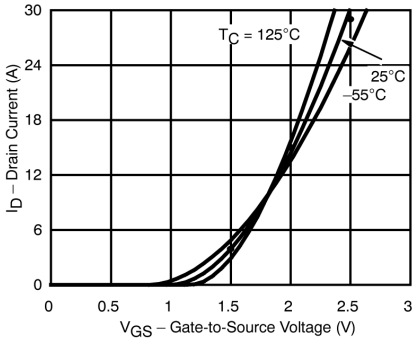
This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.

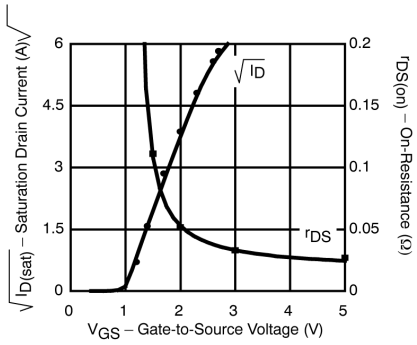
SPECIFICATIONS (T_J = 25°C UNLESS OTHERWISE NOTED)				
Parameter	**Symbol**	**Test Conditions**	**Typical**	**Unit**
Static				
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = –250 µA	0.83	V
On-State Drain Current[a]	$I_{D(on)}$	V_{DS} = – V, V_{GS} = – V		A
Drain-Source On-State Resistance[a]	$r_{DS(on)}$	V_{GS} = – V, I_D = – A		Ω
		V_{GS} = – V, I_D = –A		
		V_{GS} = – V, I_D = –A		
Forward Transconductance[a]	g_{fs}	V_{DS} = – V, I_D = – A		S
Diode Forward Voltage[a]	V_{SD}	I_S = – A, V_{GS} = 0 V		V
Dynamic[b]				
Total Gate Charge	Q_g	V_{DS} = – V, V_{GS} = – V, I_D = – A		nC
Gate-Source Charge	Q_{gs}			
Gate-Drain Charge	Q_{gd}			
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = – V, R_L = Ω I_D ≅ – A, V_{GEN} = – V, R_G = Ω		ns
Rise Time	t_r			
Turn-Off Delay Time	$t_{d(off)}$			
Fall Time	t_f			
Source-Drain Reverse Recovery Time	t_{rr}	I_F = – A, di/dt = 100 A/µs		

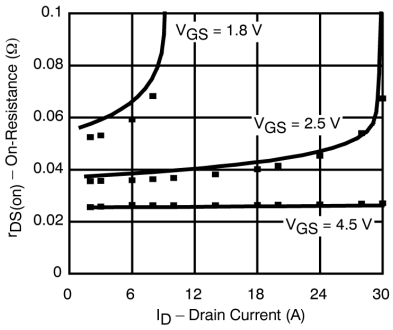
Notes
a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2%.
b. Guaranteed by design, not subject to production testing.

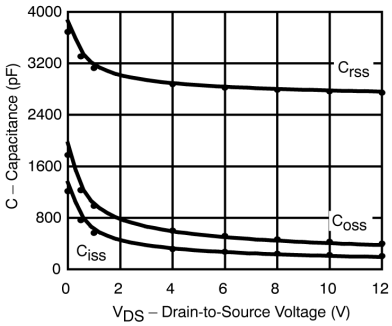
COMPARISON OF MODEL WITH MEASURED DATA (T_J=25°C UNLESS OTHERWISE NOTED)

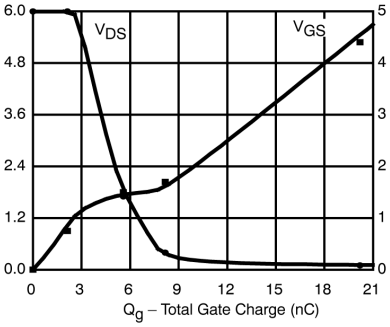












Note: Dots and squares represent measured data.